

To all our customers

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Renesas Technology Corp.  
Customer Support Dept.  
April 1, 2003

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# HM62W8512B Series

4 M SRAM (512-kword  $\times$  8-bit)



ADE-203-904F (Z)

Rev. 5.0

Mar. 15, 2000

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## Description

The Hitachi HM62W8512B is a 4-Mbit static RAM organized 512-kword  $\times$  8-bit. It realizes higher density, higher performance and low power consumption by employing 0.35  $\mu$ m Hi-CMOS process technology. The device, packaged in a 525-mil SOP (foot print pitch width) or 400-mil TSOP TYPE II is available for high density mounting. The HM62W8512B is suitable for battery backup system.

## Features

- Single 3.3 V supply: 3.3 V  $\pm$  0.3 V
- Access time: 55/70 ns (max)
- Power dissipation
  - Active: 16.5 mW/MHz (typ)
  - Standby: 3.3  $\mu$ W (typ)
- Completely static memory. No clock or timing strobe required
- Equal access and cycle times
- Common data input and output: Three state output
- Directly LV-TTL compatible: All inputs and outputs
- Battery backup operation

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## HM62W8512B Series

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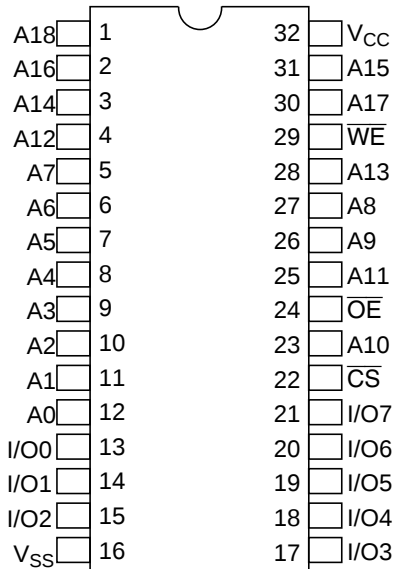
### Ordering Information

| Type No.          | Access time | Package                                           |
|-------------------|-------------|---------------------------------------------------|
| HM62W8512BLFP-5   | 55 ns       | 525-mil 32-pin plastic SOP (FP-32D)               |
| HM62W8512BLFP-7   | 70 ns       |                                                   |
| HM62W8512BLFP-5SL | 55 ns       |                                                   |
| HM62W8512BLFP-7SL | 70 ns       |                                                   |
| HM62W8512BLFP-5UL | 55 ns       |                                                   |
| HM62W8512BLFP-7UL | 70 ns       |                                                   |
| HM62W8512BLTT-5   | 55 ns       | 400-mil 32-pin plastic TSOP II (TTP-32D)          |
| HM62W8512BLTT-7   | 70 ns       |                                                   |
| HM62W8512BLTT-5SL | 55 ns       |                                                   |
| HM62W8512BLTT-7SL | 70 ns       |                                                   |
| HM62W8512BLTT-5UL | 55 ns       |                                                   |
| HM62W8512BLTT-7UL | 70 ns       |                                                   |
| HM62W8512BLRR-5   | 55 ns       | 400-mil 32-pin plastic TSOP II reverse (TTP-32DR) |
| HM62W8512BLRR-7   | 70 ns       |                                                   |
| HM62W8512BLRR-5SL | 55 ns       |                                                   |
| HM62W8512BLRR-7SL | 70 ns       |                                                   |
| HM62W8512BLRR-5UL | 55 ns       |                                                   |
| HM62W8512BLRR-7UL | 70 ns       |                                                   |

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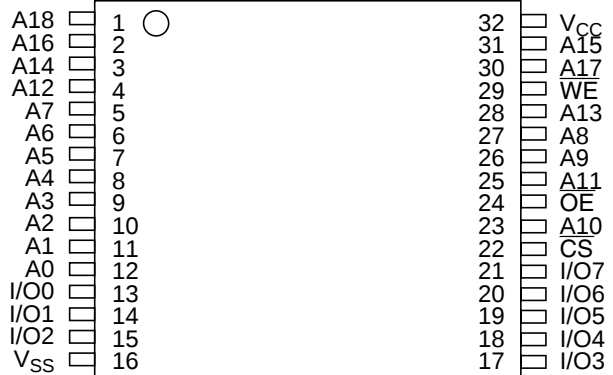
## Pin Arrangement

HM62W8512BLFP Series



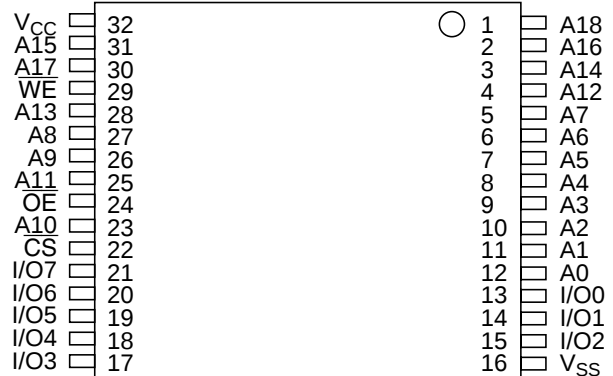
(Top view)

HM62W8512BLTT Series



(Top view)

HM62W8512BLRR Series

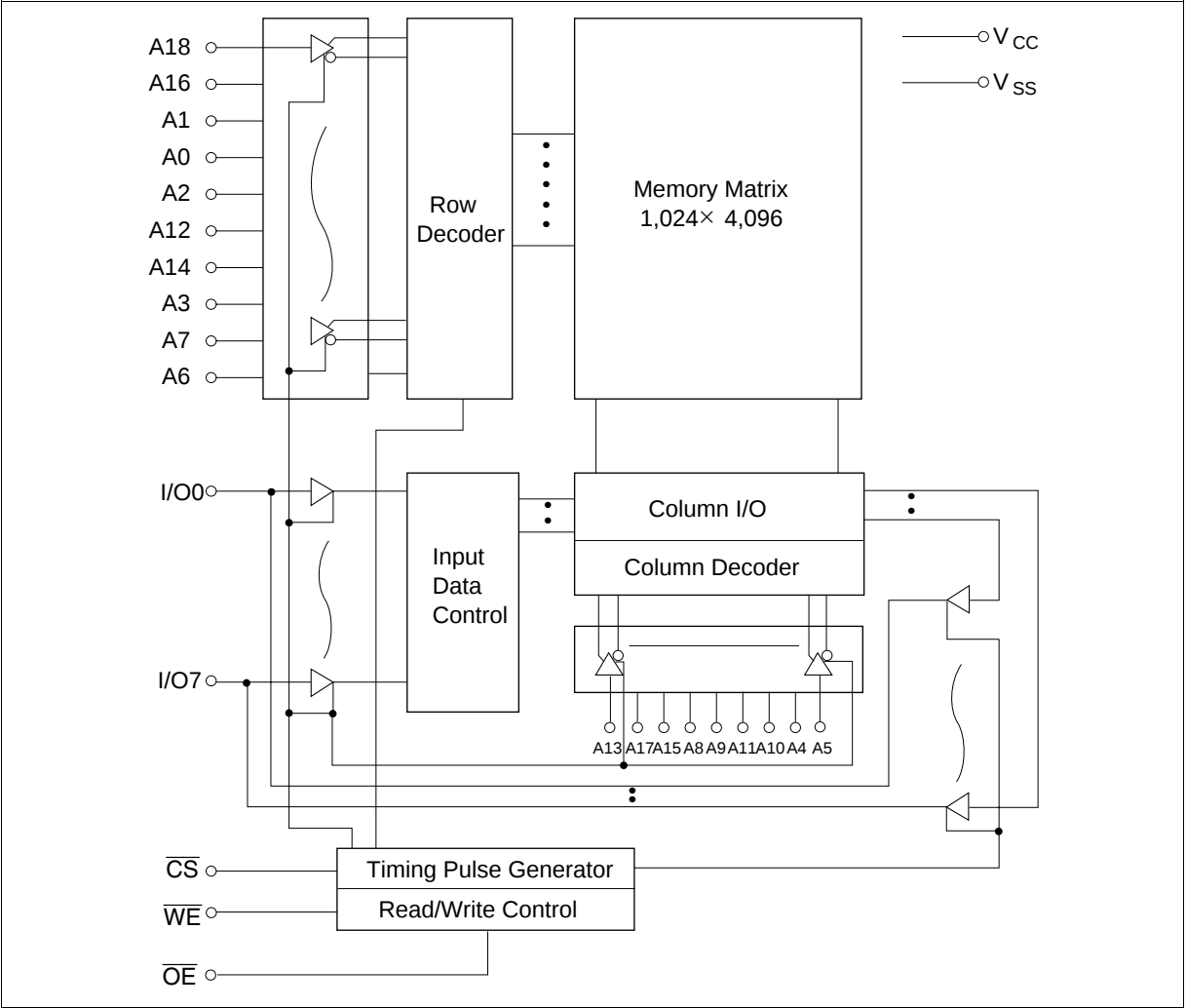


(Top view)

## Pin Description

| Pin name        | Function          |
|-----------------|-------------------|
| A0 to A18       | Address input     |
| I/O0 to I/O7    | Data input/output |
| $\overline{CS}$ | Chip select       |
| $\overline{OE}$ | Output enable     |
| $\overline{WE}$ | Write enable      |
| $V_{CC}$        | Power supply      |
| $V_{SS}$        | Ground            |

Block Diagram



## Function Table

| $\overline{WE}$ | $\overline{CS}$ | $\overline{OE}$ | Mode           | $V_{CC}$ current  | Dout pin | Ref. cycle      |
|-----------------|-----------------|-----------------|----------------|-------------------|----------|-----------------|
| X               | H               | X               | Not selected   | $I_{SB}, I_{SB1}$ | High-Z   | —               |
| H               | L               | H               | Output disable | $I_{CC}$          | High-Z   | —               |
| H               | L               | L               | Read           | $I_{CC}$          | Dout     | Read cycle      |
| L               | L               | H               | Write          | $I_{CC}$          | Din      | Write cycle (1) |
| L               | L               | L               | Write          | $I_{CC}$          | Din      | Write cycle (2) |

Note: X: H or L

## Absolute Maximum Ratings

| Parameter                               | Symbol     | Value                                               | Unit |
|-----------------------------------------|------------|-----------------------------------------------------|------|
| Power supply voltage                    | $V_{CC}$   | −0.5 to +4.6                                        | V    |
| Voltage on any pin relative to $V_{SS}$ | $V_T$      | −0.5* <sup>1</sup> to $V_{CC} + 0.5$ * <sup>2</sup> | V    |
| Power dissipation                       | $P_T$      | 1.0                                                 | W    |
| Operating temperature                   | $T_{opr}$  | −20 to +70                                          | °C   |
| Storage temperature                     | $T_{stg}$  | −55 to +125                                         | °C   |
| Storage temperature under bias          | $T_{bias}$ | −20 to +85                                          | °C   |

Notes: 1. −3.0 V for pulse half-width ≤ 30 ns

2. Maximum voltage is 4.6 V

## Recommended DC Operating Conditions ( $T_a = -20$ to $+70^\circ\text{C}$ )

| Parameter          | Symbol   | Min                | Typ | Max            | Unit |
|--------------------|----------|--------------------|-----|----------------|------|
| Supply voltage     | $V_{CC}$ | 3.0                | 3.3 | 3.6            | V    |
|                    | $V_{SS}$ | 0                  | 0   | 0              | V    |
| Input high voltage | $V_{IH}$ | 2.0                | —   | $V_{CC} + 0.3$ | V    |
| Input low voltage  | $V_{IL}$ | −0.3* <sup>1</sup> | —   | 0.8            | V    |

Note: 1. −3.0 V for pulse half-width ≤ 30 ns

## HM62W8512B Series

### DC Characteristics (Ta = -20 to +70°C, V<sub>CC</sub> = 3.3 V ± 0.3 V, V<sub>SS</sub> = 0 V)

| Parameter                            | Symbol                        | Min                   | Typ* <sup>1</sup> | Max              | Unit | Test conditions                                                                                                                                             |
|--------------------------------------|-------------------------------|-----------------------|-------------------|------------------|------|-------------------------------------------------------------------------------------------------------------------------------------------------------------|
| Input leakage current                | I <sub>IL</sub>               | —                     | —                 | 1                | μA   | V <sub>in</sub> = V <sub>SS</sub> to V <sub>CC</sub>                                                                                                        |
| Output leakage current               | I <sub>LO</sub>               | —                     | —                 | 1                | μA   | $\overline{CS} = V_{IH}$ or $\overline{OE} = V_{IH}$ or $\overline{WE} = V_{IL}$ , V <sub>I/O</sub> = V <sub>SS</sub> to V <sub>CC</sub>                    |
| Operating power supply current: DC   | I <sub>CC</sub>               | —                     | —                 | 10               | mA   | $\overline{CS} = V_{IL}$ , others = V <sub>IH</sub> /V <sub>IL</sub> , I <sub>I/O</sub> = 0 mA                                                              |
| Operating power supply current       | HM62W8512B-5 I <sub>CC1</sub> | —                     | —                 | 45               | mA   | Min cycle, duty = 100%<br>$\overline{CS} = V_{IL}$ , others = V <sub>IH</sub> /V <sub>IL</sub><br>I <sub>I/O</sub> = 0 mA                                   |
|                                      | HM62W8512B-7 I <sub>CC1</sub> | —                     | —                 | 40               | mA   |                                                                                                                                                             |
| Operating power supply current       | I <sub>CC2</sub>              | —                     | 5                 | 10               | mA   | Cycle time = 1 μs, duty = 100%<br>I <sub>I/O</sub> = 0 mA, $\overline{CS} \leq 0.2$ V<br>V <sub>IH</sub> ≥ V <sub>CC</sub> - 0.2 V, V <sub>IL</sub> ≤ 0.2 V |
| Standby power supply current: DC     | I <sub>SB</sub>               | —                     | 0.1               | 0.3              | mA   | $\overline{CS} = V_{IH}$                                                                                                                                    |
| Standby power supply current (1): DC | I <sub>SB1</sub>              | —                     | 1* <sup>2</sup>   | 40* <sup>2</sup> | μA   | V <sub>in</sub> ≥ 0 V,<br>$\overline{CS} \geq V_{CC} - 0.2$ V                                                                                               |
|                                      |                               | —                     | 1* <sup>3</sup>   | 20* <sup>3</sup> | μA   |                                                                                                                                                             |
|                                      |                               | —                     | 1* <sup>4</sup>   | 5* <sup>4</sup>  | μA   |                                                                                                                                                             |
| Output low voltage                   | V <sub>OL</sub>               | —                     | —                 | 0.4              | V    | I <sub>OL</sub> = 2.0 mA                                                                                                                                    |
|                                      |                               | —                     | —                 | 0.2              | V    | I <sub>OL</sub> = 100 μA                                                                                                                                    |
| Output high voltage                  | V <sub>OH</sub>               | V <sub>CC</sub> - 0.2 | —                 | —                | V    | I <sub>OH</sub> = -100 μA                                                                                                                                   |
|                                      |                               | 2.4                   | —                 | —                | V    | I <sub>OH</sub> = -2.0 mA                                                                                                                                   |

Notes: 1. Typical values are at V<sub>CC</sub> = 3.3 V, Ta = +25°C and specified loading, and not guaranteed.

2. This characteristics is guaranteed only for L version.

3. This characteristics is guaranteed only for L-SL version.

4. This characteristics is guaranteed only for L-UL version.

### Capacitance (Ta = +25°C, f = 1 MHz)

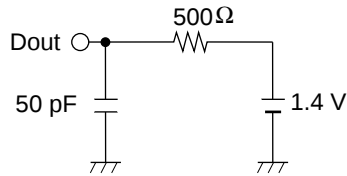
| Parameter                              | Symbol           | Typ | Max | Unit | Test conditions        |
|----------------------------------------|------------------|-----|-----|------|------------------------|
| Input capacitance* <sup>1</sup>        | C <sub>in</sub>  | —   | 8   | pF   | V <sub>in</sub> = 0 V  |
| Input/output capacitance* <sup>1</sup> | C <sub>I/O</sub> | —   | 10  | pF   | V <sub>I/O</sub> = 0 V |

Note: 1. This parameter is sampled and not 100% tested.

**AC Characteristics** ( $T_a = -20$  to  $+70^\circ\text{C}$ ,  $V_{CC} = 3.3\text{ V} \pm 0.3\text{ V}$ , unless otherwise noted.)

**Test Conditions**

- Input pulse levels: 0.4 V to 2.4 V
- Input rise and fall time: 5 ns
- Input timing reference levels: 1.4 V
- Output timing reference level: 1.4 V/1.4 V(HM62W8512B-5)  
0.8 V/2.0 V(HM62W8512B-7)
- Output load (Including scope & jig)



**Read Cycle**

**HM62W8512B**

**-5                      -7**

| Parameter                            | Symbol    | Min | Max | Min | Max | Unit | Notes |
|--------------------------------------|-----------|-----|-----|-----|-----|------|-------|
| Read cycle time                      | $t_{RC}$  | 55  | —   | 70  | —   | ns   |       |
| Address access time                  | $t_{AA}$  | —   | 55  | —   | 70  | ns   |       |
| Chip select access time              | $t_{CO}$  | —   | 55  | —   | 70  | ns   |       |
| Output enable to output valid        | $t_{OE}$  | —   | 30  | —   | 35  | ns   |       |
| Chip selection to output in low-Z    | $t_{LZ}$  | 10  | —   | 10  | —   | ns   | 2     |
| Output enable to output in low-Z     | $t_{OLZ}$ | 5   | —   | 5   | —   | ns   | 2     |
| Chip deselection to output in high-Z | $t_{HZ}$  | 0   | 20  | 0   | 30  | ns   | 1, 2  |
| Output disable to output in high-Z   | $t_{OHZ}$ | 0   | 20  | 0   | 30  | ns   | 1, 2  |
| Output hold from address change      | $t_{OH}$  | 10  | —   | 10  | —   | ns   |       |

## Write Cycle

HM62W8512B

| Parameter                           | Symbol    | -5  |     | -7  |     | Unit | Notes   |
|-------------------------------------|-----------|-----|-----|-----|-----|------|---------|
|                                     |           | Min | Max | Min | Max |      |         |
| Write cycle time                    | $t_{WC}$  | 55  | —   | 70  | —   | ns   |         |
| Chip selection to end of write      | $t_{CW}$  | 50  | —   | 60  | —   | ns   | 4       |
| Address setup time                  | $t_{AS}$  | 0   | —   | 0   | —   | ns   | 5       |
| Address valid to end of write       | $t_{AW}$  | 50  | —   | 60  | —   | ns   |         |
| Write pulse width                   | $t_{WP}$  | 40  | —   | 50  | —   | ns   | 3, 12   |
| Write recovery time                 | $t_{WR}$  | 0   | —   | 0   | —   | ns   | 6       |
| $\overline{WE}$ to output in high-Z | $t_{WHZ}$ | 0   | 20  | 0   | 30  | ns   | 1, 2, 7 |
| Data to write time overlap          | $t_{DW}$  | 25  | —   | 30  | —   | ns   |         |
| Data hold from write time           | $t_{DH}$  | 0   | —   | 0   | —   | ns   |         |
| Output active from output in high-Z | $t_{OW}$  | 5   | —   | 5   | —   | ns   | 2       |
| Output disable to output in high-Z  | $t_{OHZ}$ | 0   | 20  | 0   | 30  | ns   | 1, 2, 7 |

Notes: 1.  $t_{HZ}$ ,  $t_{OHZ}$  and  $t_{WHZ}$  are defined as the time at which the outputs achieve the open circuit conditions and are not referred to output voltage levels.

2. This parameter is sampled and not 100% tested.

3. A write occurs during the overlap ( $t_{WP}$ ) of a low  $\overline{CS}$  and a low  $\overline{WE}$ . A write begins at the later transition of  $\overline{CS}$  going low or  $\overline{WE}$  going low. A write ends at the earlier transition of  $\overline{CS}$  going high or  $\overline{WE}$  going high.  $t_{WP}$  is measured from the beginning of write to the end of write.

4.  $t_{CW}$  is measured from  $\overline{CS}$  going low to the end of write.

5.  $t_{AS}$  is measured from the address valid to the beginning of write.

6.  $t_{WR}$  is measured from the earlier of  $\overline{WE}$  or  $\overline{CS}$  going high to the end of write cycle.

7. During this period, I/O pins are in the output state so that the input signals of the opposite phase to the outputs must not be applied.

8. If the  $\overline{CS}$  low transition occurs simultaneously with the  $\overline{WE}$  low transition or after the  $\overline{WE}$  transition, the output remain in a high impedance state.

9. Dout is the same phase of the write data of this write cycle.

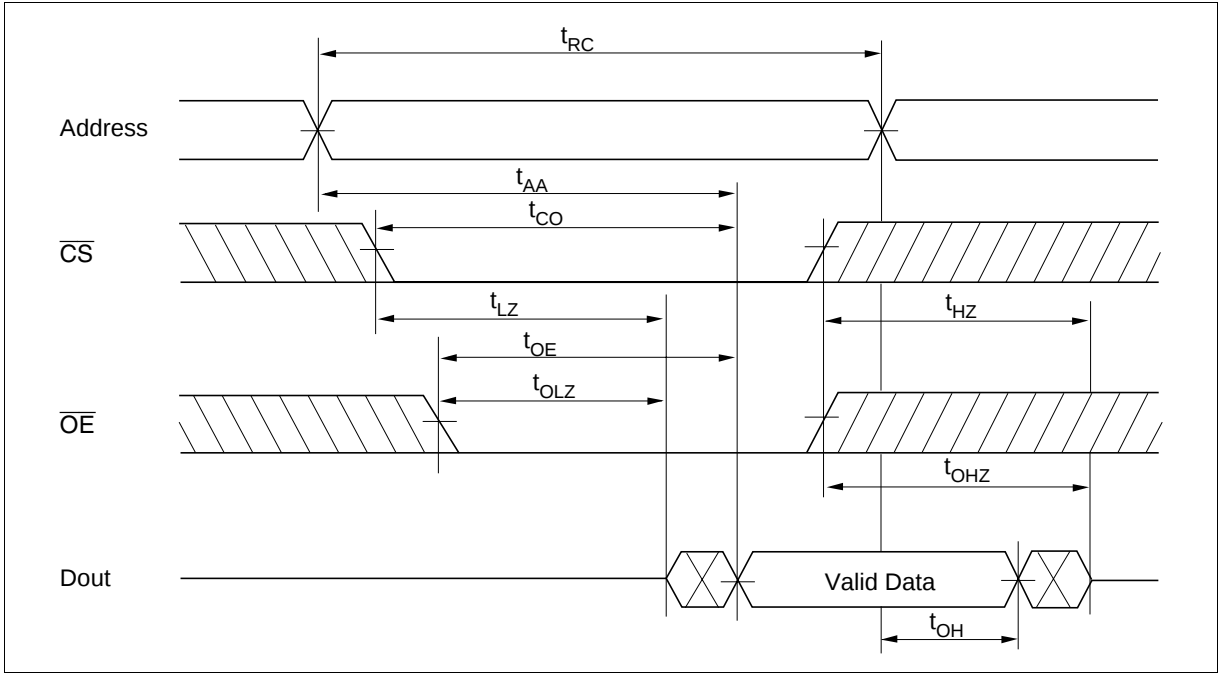
10. Dout is the read data of next address.

11. If  $\overline{CS}$  is low during this period, I/O pins are in the output state. Therefore, the input signals of the opposite phase to the outputs must not be applied to them.

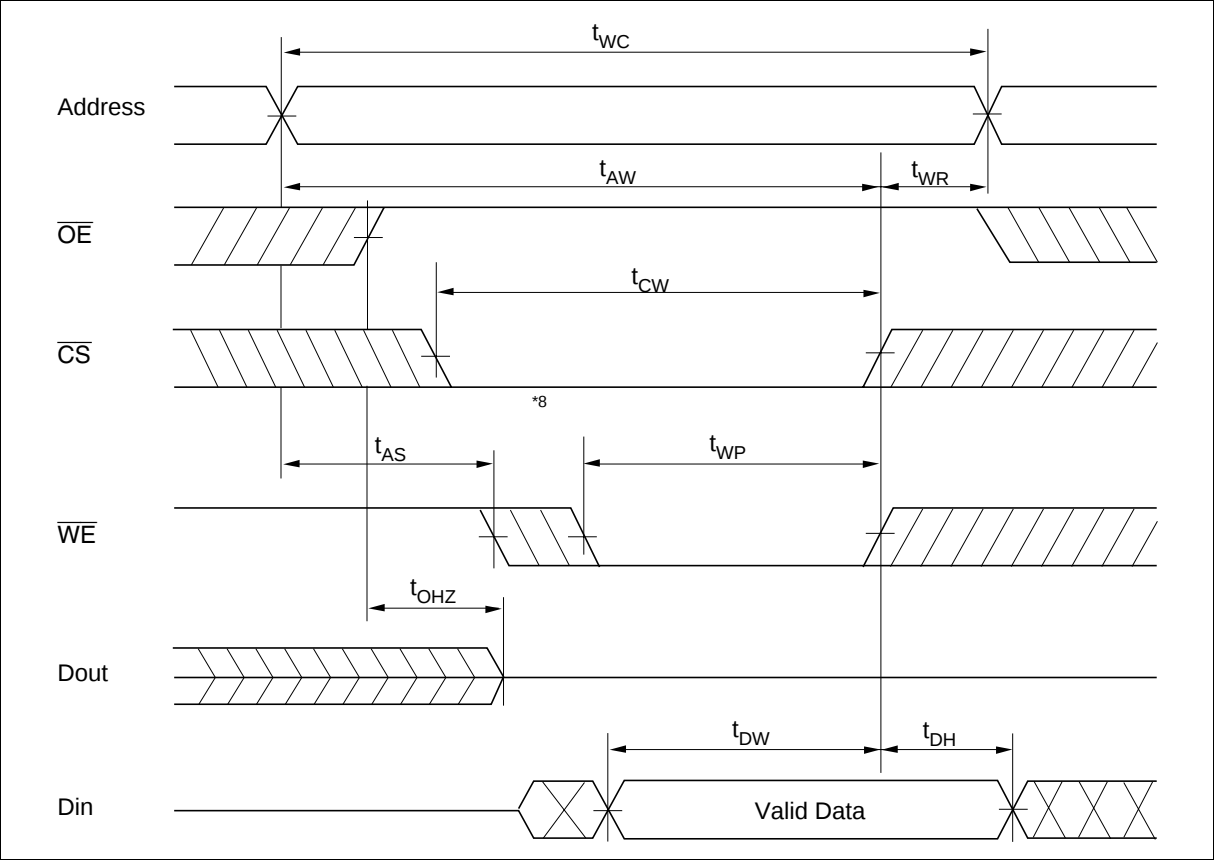
12. In the write cycle with  $\overline{OE}$  low fixed,  $t_{WP}$  must satisfy the following equation to avoid a problem of data bus contention.  $t_{WP} \geq t_{DW} \text{ min} + t_{WHZ} \text{ max}$

## Timing Waveforms

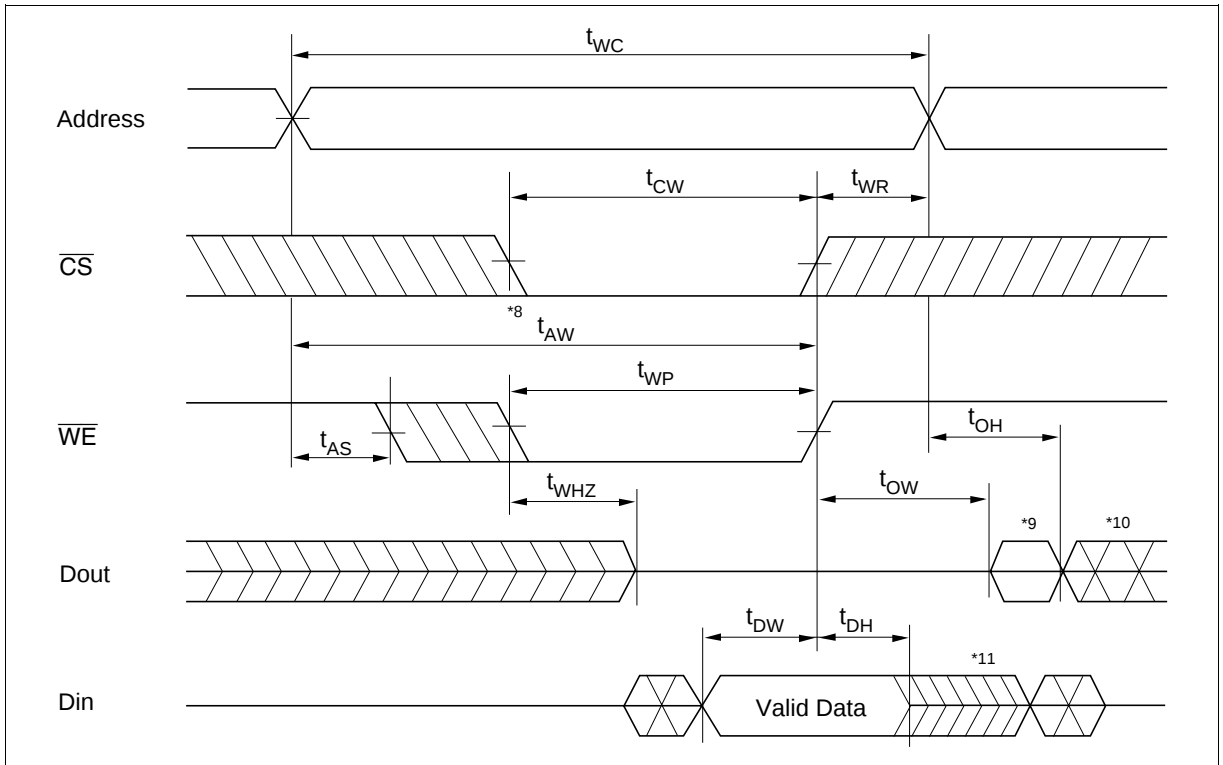
### Read Timing Waveform ( $\overline{WE} = V_{IH}$ )



Write Timing Waveform (1) ( $\overline{\text{OE}}$  Clock)



Write Timing Waveform (2) ( $\overline{\text{OE}}$  Low Fixed)

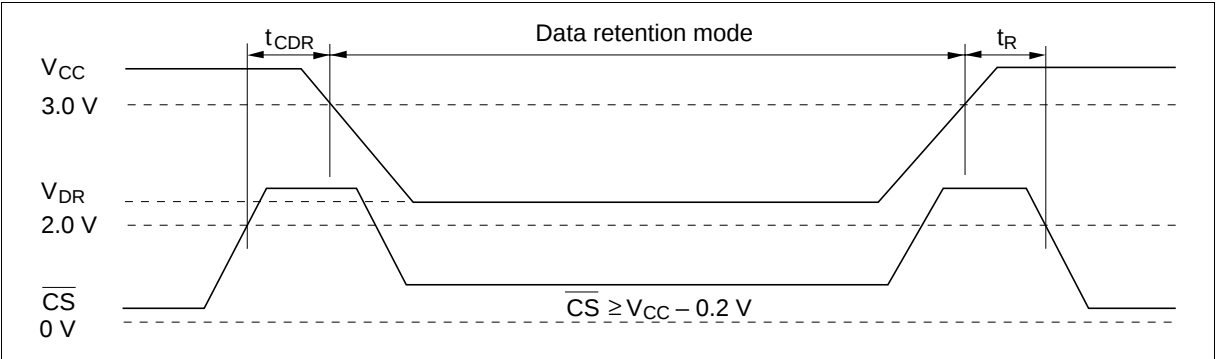


Low V<sub>CC</sub> Data Retention Characteristics (Ta = -20 to +70°C)

| Parameter                            | Symbol            | Min                | Typ   | Max  | Unit | Test conditions*4                                                                 |
|--------------------------------------|-------------------|--------------------|-------|------|------|-----------------------------------------------------------------------------------|
| V <sub>CC</sub> for data retention   | V <sub>DR</sub>   | 2                  | —     | —    | V    | $\overline{CS} \geq V_{CC} - 0.2\text{ V}$ , Vin ≥ 0 V                            |
| Data retention current               | I <sub>CDDR</sub> | —                  | 0.8*5 | 20*1 | μA   | $V_{CC} = 3.0\text{ V}$ , Vin ≥ 0 V<br>$\overline{CS} \geq V_{CC} - 0.2\text{ V}$ |
|                                      |                   | —                  | 0.8*5 | 10*2 | μA   |                                                                                   |
|                                      |                   | —                  | 0.8*5 | 2*3  | μA   |                                                                                   |
| Chip deselect to data retention time | t <sub>CDR</sub>  | 0                  | —     | —    | ns   | See retention waveform                                                            |
| Operation recovery time              | t <sub>R</sub>    | t <sub>RC</sub> *6 | —     | —    | ns   |                                                                                   |

- Notes:
- 1. For L-version and 10 μA (max.) at Ta = -20 to +40°C.
  - 2. For L-SL-version and 3 μA (max.) at Ta = -20 to +40°C.
  - 3. For L-UL-version and 2 μA (max.) at Ta = -20 to +40°C.
  - 4.  $\overline{CS}$  controls address buffer,  $\overline{WE}$  buffer,  $\overline{OE}$  buffer, and Din buffer. In data retention mode, Vin levels (address,  $\overline{WE}$ ,  $\overline{OE}$ , I/O) can be in the high impedance state.
  - 5. Typical values are at V<sub>CC</sub> = 3.0 V, Ta = +25°C and specified loading, and not guaranteed.
  - 6. t<sub>RC</sub> = read cycle time.

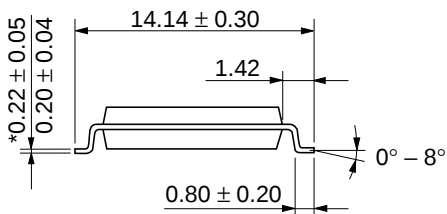
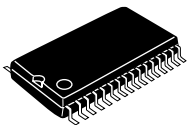
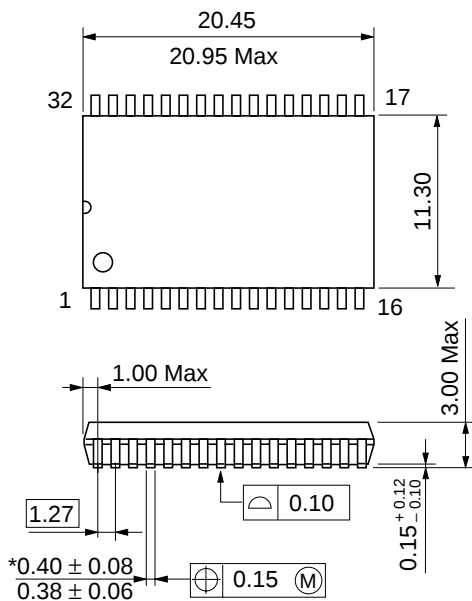
Low V<sub>CC</sub> Data Retention Timing Waveform ( $\overline{CS}$  Controlled)



Package Dimensions

HM62W8512BLFP Series (FP-32D)

Unit: mm



\*Dimension including the plating thickness  
Base material dimension

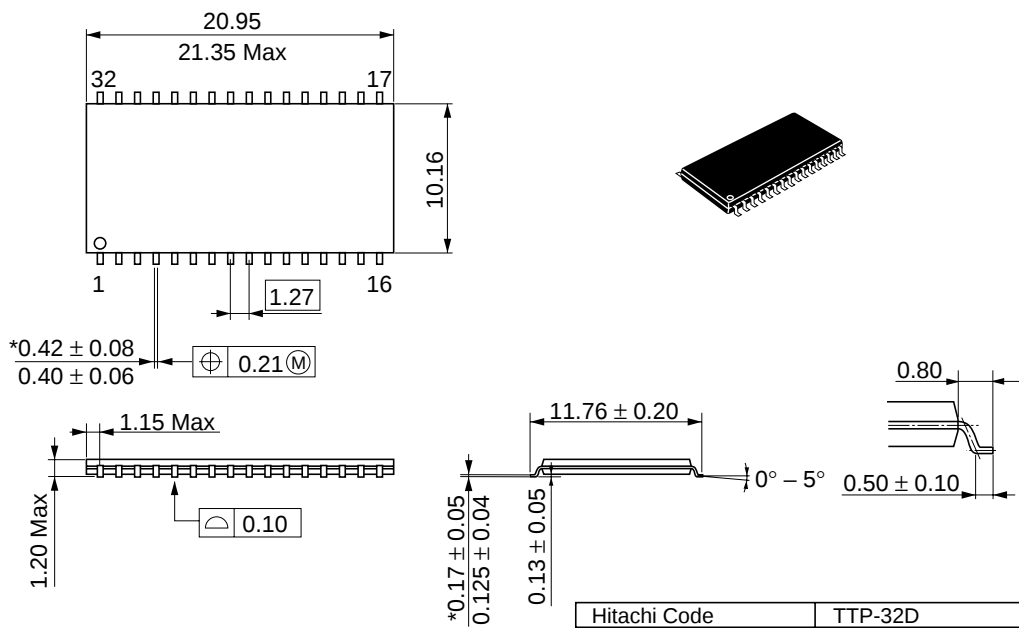
|                          |          |
|--------------------------|----------|
| Hitachi Code             | FP-32D   |
| JEDEC                    | Conforms |
| EIAJ                     | —        |
| Weight (reference value) | 1.3 g    |

HM62W8512B Series

Package Dimensions (cont.)

HM62W8512BLTT Series (TTP-32D)

Unit: mm



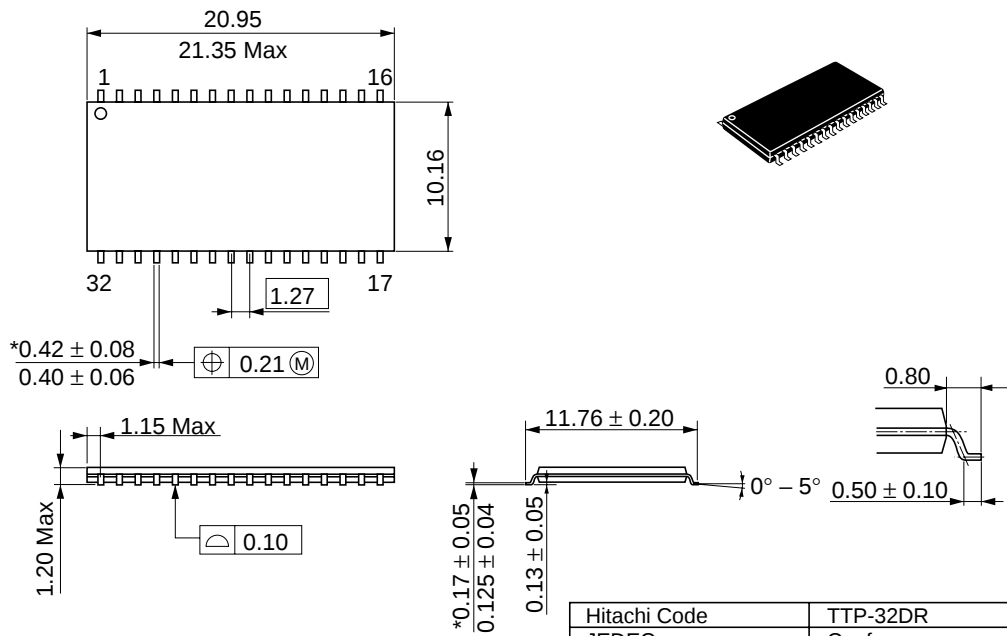
\*Dimension including the plating thickness  
Base material dimension

|                          |          |
|--------------------------|----------|
| Hitachi Code             | TTP-32D  |
| JEDEC                    | Conforms |
| EIAJ                     | —        |
| Weight (reference value) | 0.51 g   |

Package Dimensions (cont.)

HM62W8512BLRR Series (TTP-32DR)

Unit: mm



\*Dimension including the plating thickness  
Base material dimension

|                          |          |
|--------------------------|----------|
| Hitachi Code             | TTP-32DR |
| JEDEC                    | Conforms |
| EIAJ                     | —        |
| Weight (reference value) | 0.51 g   |

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